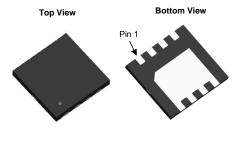
PRODUCT SUMMARY					
V _{DS} (V)	R _{DS(on)} (Ω) (Max.)	I _D (A)	Q _g (Typ.)		
- 20	0.005 at V _{GS} = - 4.5 V	- 52 ^a	93 nC		
20	0.006 at V _{GS} = - 2.5 V	- 39 ^a	93 NC		

DFN 3x3 EP

Din-Tek

SEMICONDUCTOR

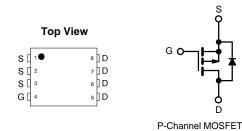


FEATURES

- DT-Trench Power MOSFET
- Thermally Enhanced DFN 3X3 Package
 - Small Footprint Area
 - Low On-Resistance

APPLICATIONS

· Load Switch, PA Switch, and Battery Switch for Portable Devices



ABSOLUTE MAXIMUM RATINGS	$(1_{A} = 25 \text{ C}, \text{ unle})$				
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	- 20	V	
Gate-Source Voltage		V _{GS}	± 12	v	
	T _C = 25 °C		- 52 ^a		
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C	I _D	- 39 ^a		
	T _A = 25 °C	טי	- 31 ^{b, c}		
	T _A = 70 °C		- 25 ^{b, c}	A	
Pulsed Drain Current (t = 300 µs)		I _{DM}	- 200	7	
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	- 52 ^a		
Continuous Source-Drain Diode Current	T _A = 25 °C	'8	- 29 ^{b, c}		
	T _C = 25 °C		89		
Maximum Power Dissipation	T _C = 70 °C	P _D	33	W	
Maximum rower Dissipation	T _A = 25 °C	' D	6.5 ^{b, c}		
	T _A = 70 °C		4.2 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	℃	
Soldering Recommendations (Peak Temperature) ^{d, e}			260		

THERMAL RESISTANCE BATINGS

Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, f}	t ≤ 5 s	R _{thJA}	18	26	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	1.3	1.5	C/VV	

Notes:

a. Package limited.

b. Surface mounted on 1" x 1" FR4 board.

c. t = 5 s.

d. See solder profile The DFN3X3 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.

e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.

f. Maximum under steady state conditions is 80 °C/W.





DTQ3205

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SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)							
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	1		- 20	T	F	T	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = - 250 μA				V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	In = - 250 µA		- 11		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			2.7			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = -250 \ \mu A$	- 0.8		- 2	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 8 V$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = -12 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			- 1	μA	
	.033	V_{DS} = - 12 V, V_{GS} = 0 V, T_{J} = 55 °C			- 10		
On-State Drain Current ^a	I _{D(on)}	V_{DS} \leq - 5 V, V_{GS} = - 4.5 V	- 20			A	
		V_{GS} = - 4.5 V, I _D = - 5.3 A		0.005	0.0065		
Drain Source On State Desistance	R _{DS(on)}	$V_{GS} = -4.5 \text{ V}, \text{ I}_{D} = -8.1 \text{ A}$		0.0053	0.007	0	
Drain-Source On-State Resistance ^a	US(on)	V_{GS} = - 2.5 V, I _D = - 5.3 A		0.006	0.008	Ω	
		V _{GS} = - 2.5 V, I _D = - 6 A		0.0065	0.009		
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 10 V, I _D = - 18.5 A		94		S	
Dynamic ^b						•	
Input Capacitance	C _{iss}			4800		pF	
Output Capacitance	C _{oss}	V _{DS} = - 10 V, V _{GS} = 0 V, f = 1 MHz		850			
Reverse Transfer Capacitance	C _{rss}			590			
Takal Oaks Observe	0	V _{DS} = - 6 V, V _{GS} = - 8 V, I _D = - 10 A		58	97	nC	
Total Gate Charge	Qg			33	65		
Gate-Source Charge	Q _{gs}	V_{DS} = - 6 V, V_{GS} = - 4.5 V, I_{D} = - 10 A		7			
Gate-Drain Charge	Q _{gd}			15.5		1	
Gate Resistance	R _g	f = 1 MHz		5		Ω	
Turn-On Delay Time	t _{d(on)}			20	30		
Rise Time	t _r	V_{DD} = - 6 V, R _L = 0.75 Ω		40	60	-	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ - 8 Å, V_{GEN} = - 4.5 V, R_g = 1 Ω		65	100		
Fall Time	t _f			40	60		
Turn-On Delay Time	t _{d(on)}			10	15	ns	
Rise Time	t _r	V_{DD} = - 6 V, R ₁ = 0.75 Ω		12	20	-	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ - 8 A, V_{GEN} = - 8 V, R_g = 1 Ω		70	105		
Fall Time	t _f			40	60		
Drain-Source Body Diode Characterist				L	L		
Continuous Source-Drain Diode Current		T _C = 25 °C			- 52		
Pulse Diode Forward Current	I _{SM}				200	A	
Body Diode Voltage	V _{SD}	I _S = - 8 A, V _{GS} = 0 V		- 0.57	- 1.1	V	
Body Diode Reverse Recovery Time	t _{rr}			40	60	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			20	30	nC	
Reverse Recovery Fall Time	t _a	$I_F = -8 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, \text{ T}_J = 25 \text{ °C}$		14			
Reverse Recovery Rise Time	t _b			26		ns	

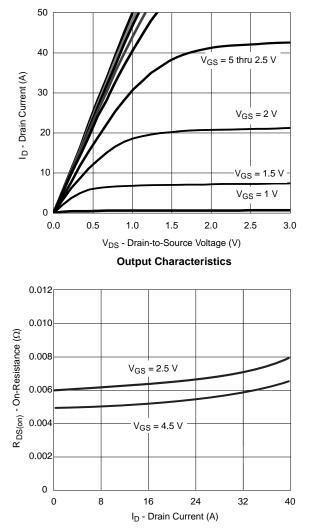
Notes:

a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.

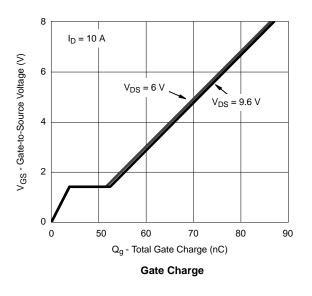
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

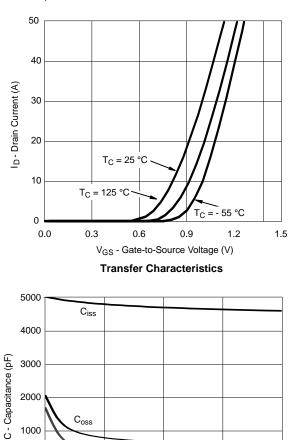


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



On-Resistance vs. Drain Current and Gate Voltage





 C_{oss}

3

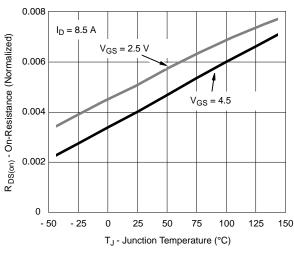
C_{rss}

1000

500

0

0



6

V_{DS} - Drain-to-Source Voltage (V)

Capacitance

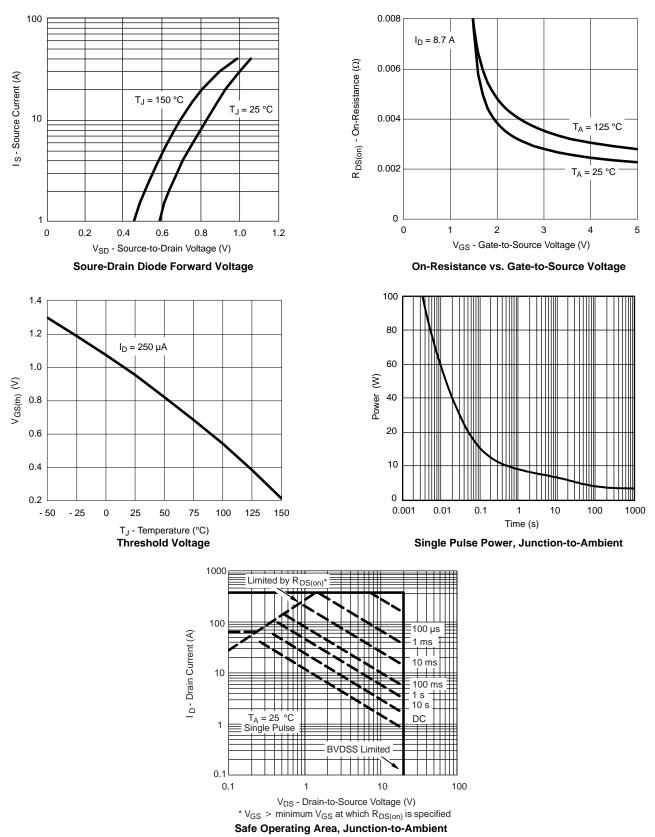
9

12

On-Resistance vs. Junction Temperature

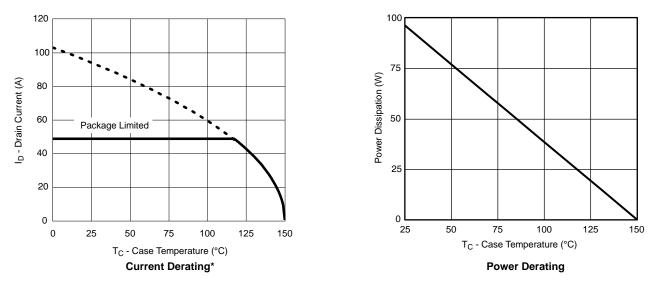




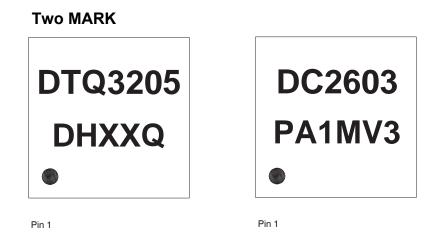








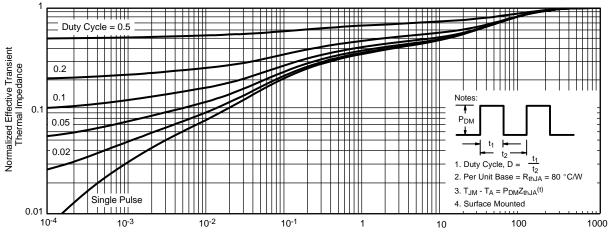
Part Marking Information



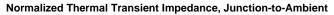
* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

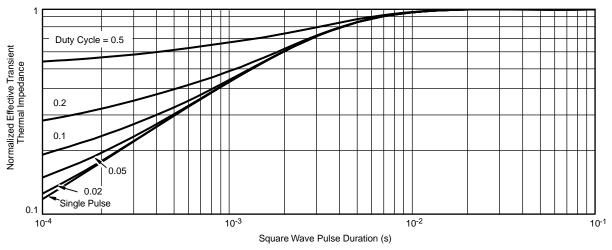


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



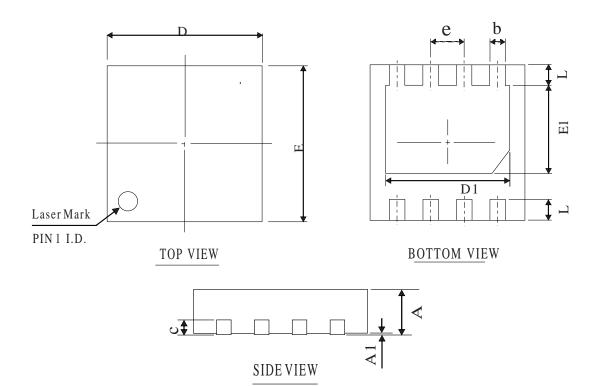
Square Wave Pulse Duration (s)





Normalized Thermal Transient Impedance, Junction-to-Case

DFN3*3-8L PACKAGE OUTLINE



COMMON DIMENSIONS (UNITS OF MEASURE=mm)

SYMBOL	MIN	NOM	MAX	
Α	0.60	0.75	0.90	
A1	0. 00	0.02	0.08	
b	0. 20	0.30	0.45	
D	2.85	3.00	3.15	
E	2. 85	3.00	3.15	
Dl	2. 10	2.40	2.70	
E1	1.50	1.70	2.00	
L	0. 20	0.40	0.60	
С	0. 203 REF			
e	0. 65 BSC			

OTHER DIMENSIONS

Α	0. 50	0.55	0.60
A	0.40	0.45	0.50



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